RMATION CITED BY APPLICANT THAT MAY BE MATERIAL TO THE PROSECUTION OF THE SUBJECT APPLICATION

Applicant:

JUN 0 3 7005

R.M. Wasserman

Attorney Docket No. MEIP122366

Application No.: 10/808,948

Group Art Unit: 2625

Filed:

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Title:

SYSTEM AND METHOD FOR EXCLUDING EXTRANEOUS FEATURES

FROM INSPECTION OPERATIONS PERFORMED BY A MACHINE

VISION INSPECTION SYSTEM

U.S. PATENT DOCUMENTS

*Examiner			Kind	Date	
<u>Initials</u>	No.	Document No.	Code	(mm/dd/yyyy)	Name
TR	U1	6,542,180	B1	04/01/2003	Wasserman et al.
TR	U2	6,627,863	B2	09/30/2003	Wasserman
TR	_ U3	2002/0076096	A1	06/20/2002	Silber et al.

FOREIGN PATENT DOCUMENTS

*Examiner Cite		Kind	Publication Date		English	
		KIIIG	I utilication Date		Abstract	Translation
Initial No.	Document No.	Code	(mm/dd/yyyy)	Country	Provided	Provided

None.

OTHER INFORMATION (Including Author, Title, Date, Pertinent Pages, Etc.)

*Examiner Initial	Cite No.	
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*Examiner	Cite				
Initial	No.				
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^{*}Examiner: Initial if reference considered, whether or not citation is in conformance with M.P.E.P. § 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

GSF:lal